

**Search Notes**

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Examiner

Mathieu D. Vargot

Applicant(s)/Patent under  
Reexamination

SAIKI ET AL.

Art Unit

1791

**SEARCHED**

Class	Subclass	Date	Examiner
264	1.1, 1.34, 2.6, 2.7, 288.4	3/22/2008	MDV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR